Application/Control No. Applicant(s)/Patent Under Reexamination 10/014,794 VAN DE VEN ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 Minh DA 2821 **U.S. PATENT DOCUMENTS** Document Number Date Country Code-Number-Kind Code Name Classification MM-YYYY Α US-6,512,624 01-2003 Tonar et al. 359/265 US-6,523,976 02-2003 В Turnbull et al. 362/231 US-6,259,838 07-2001 С Singh et al. 385/31 US-6,265,984 07-2001 D Molinaroli, Carl Joseph 340/815.4 Ε US-F US-US-G US-Н US-1 US-US-Κ Ļ US-US-М

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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